

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Ferrite cores – Guidelines on the limits of surface irregularities –
Part 3: ETD-cores, EER-cores, EC-cores and E-cores**

**Noyaux ferrites – Lignes directrices relatives aux limites des irrégularités de
surface –
Partie 3: Noyaux ETD, EER, EC et E**



THIS PUBLICATION IS COPYRIGHT PROTECTED

Copyright © 2015 IEC, Geneva, Switzerland

All rights reserved. Unless otherwise specified, no part of this publication may be reproduced or utilized in any form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from either IEC or IEC's member National Committee in the country of the requester. If you have any questions about IEC copyright or have an enquiry about obtaining additional rights to this publication, please contact the address below or your local IEC member National Committee for further information.

Droits de reproduction réservés. Sauf indication contraire, aucune partie de cette publication ne peut être reproduite ni utilisée sous quelque forme que ce soit et par aucun procédé, électronique ou mécanique, y compris la photocopie et les microfilms, sans l'accord écrit de l'IEC ou du Comité national de l'IEC du pays du demandeur. Si vous avez des questions sur le copyright de l'IEC ou si vous désirez obtenir des droits supplémentaires sur cette publication, utilisez les coordonnées ci-après ou contactez le Comité national de l'IEC de votre pays de résidence.

IEC Central Office
3, rue de Varembe
CH-1211 Geneva 20
Switzerland

Tel.: +41 22 919 02 11
Fax: +41 22 919 03 00
info@iec.ch
www.iec.ch

About the IEC

The International Electrotechnical Commission (IEC) is the leading global organization that prepares and publishes International Standards for all electrical, electronic and related technologies.

About IEC publications

The technical content of IEC publications is kept under constant review by the IEC. Please make sure that you have the latest edition, a corrigenda or an amendment might have been published.

IEC Catalogue - webstore.iec.ch/catalogue

The stand-alone application for consulting the entire bibliographical information on IEC International Standards, Technical Specifications, Technical Reports and other documents. Available for PC, Mac OS, Android Tablets and iPad.

IEC publications search - www.iec.ch/searchpub

The advanced search enables to find IEC publications by a variety of criteria (reference number, text, technical committee,...). It also gives information on projects, replaced and withdrawn publications.

IEC Just Published - webstore.iec.ch/justpublished

Stay up to date on all new IEC publications. Just Published details all new publications released. Available online and also once a month by email.

Electropedia - www.electropedia.org

The world's leading online dictionary of electronic and electrical terms containing more than 30 000 terms and definitions in English and French, with equivalent terms in 15 additional languages. Also known as the International Electrotechnical Vocabulary (IEV) online.

IEC Glossary - std.iec.ch/glossary

More than 60 000 electrotechnical terminology entries in English and French extracted from the Terms and Definitions clause of IEC publications issued since 2002. Some entries have been collected from earlier publications of IEC TC 37, 77, 86 and CISPR.

IEC Customer Service Centre - webstore.iec.ch/csc

If you wish to give us your feedback on this publication or need further assistance, please contact the Customer Service Centre: csc@iec.ch.

A propos de l'IEC

La Commission Electrotechnique Internationale (IEC) est la première organisation mondiale qui élabore et publie des Normes internationales pour tout ce qui a trait à l'électricité, à l'électronique et aux technologies apparentées.

A propos des publications IEC

Le contenu technique des publications IEC est constamment revu. Veuillez vous assurer que vous possédez l'édition la plus récente, un corrigendum ou amendement peut avoir été publié.

Catalogue IEC - webstore.iec.ch/catalogue

Application autonome pour consulter tous les renseignements bibliographiques sur les Normes internationales, Spécifications techniques, Rapports techniques et autres documents de l'IEC. Disponible pour PC, Mac OS, tablettes Android et iPad.

Recherche de publications IEC - www.iec.ch/searchpub

La recherche avancée permet de trouver des publications IEC en utilisant différents critères (numéro de référence, texte, comité d'études,...). Elle donne aussi des informations sur les projets et les publications remplacées ou retirées.

IEC Just Published - webstore.iec.ch/justpublished

Restez informé sur les nouvelles publications IEC. Just Published détaille les nouvelles publications parues. Disponible en ligne et aussi une fois par mois par email.

Electropedia - www.electropedia.org

Le premier dictionnaire en ligne de termes électroniques et électriques. Il contient plus de 30 000 termes et définitions en anglais et en français, ainsi que les termes équivalents dans 15 langues additionnelles. Egalement appelé Vocabulaire Electrotechnique International (IEV) en ligne.

Glossaire IEC - std.iec.ch/glossary

Plus de 60 000 entrées terminologiques électrotechniques, en anglais et en français, extraites des articles Termes et Définitions des publications IEC parues depuis 2002. Plus certaines entrées antérieures extraites des publications des CE 37, 77, 86 et CISPR de l'IEC.

Service Clients - webstore.iec.ch/csc

Si vous désirez nous donner des commentaires sur cette publication ou si vous avez des questions contactez-nous: csc@iec.ch.

INTERNATIONAL STANDARD

NORME INTERNATIONALE

**Ferrite cores – Guidelines on the limits of surface irregularities –
Part 3: ETD-cores, EER-cores, EC-cores and E-cores**

**Noyaux ferrites – Lignes directrices relatives aux limites des irrégularités de
surface –
Partie 3: Noyaux ETD, EER, EC et E**

INTERNATIONAL
ELECTROTECHNICAL
COMMISSION

COMMISSION
ELECTROTECHNIQUE
INTERNATIONALE

ICS 29.100.10

ISBN 978-2-8322-2936-1

**Warning! Make sure that you obtained this publication from an authorized distributor.
Attention! Veuillez vous assurer que vous avez obtenu cette publication via un distributeur agréé.**

CONTENTS

FOREWORD	3
1 Scope	5
2 Normative references	5
3 Terms and definitions	5
4 Limits of surface irregularities	6
4.1 Chips and ragged edges	6
4.1.1 General	6
4.1.2 Chips and ragged edges on the mating surfaces	6
4.1.3 Chips and ragged edges on other surfaces	6
4.2 Cracks	11
4.3 Flash	11
4.4 Pull-outs	11
4.5 Crystallites	14
4.6 Pores	14
Figure 1 – Chip location for ETD-cores, EER-cores and EC-cores	9
Figure 2 – Chip location for E-cores	9
Figure 3 – Cracks and pull-out location for ETD-cores, EER-cores and EC-cores	12
Figure 4 – Cracks and pull-out location for E-cores	13
Figure 5 – Crystallites location for ETD-cores, EER-cores and EC-cores	14
Figure 6 – Crystallites location for E-cores	14
Figure 7 – Pores location for ETD-cores, EER-cores and EC-cores	15
Figure 8 – Pores location for E-cores	15
Table 1 – Allowable areas of chips for ETD-cores in mm ²	6
Table 2 – Allowable areas of chips for EER-cores in mm ²	7
Table 3 – Allowable areas of chips for EC-cores in mm ²	7
Table 4 – Allowable areas of chips for E-cores in mm ²	8
Table 5 – Area and length reference for visual inspection	10
Table 6 – Limits for cracks	13

INTERNATIONAL ELECTROTECHNICAL COMMISSION

**FERRITE CORES – GUIDELINES ON
THE LIMITS OF SURFACE IRREGULARITIES –****Part 3: ETD-cores, EER-cores, EC-cores and E-cores**

FOREWORD

- 1) The International Electrotechnical Commission (IEC) is a worldwide organization for standardization comprising all national electrotechnical committees (IEC National Committees). The object of IEC is to promote international co-operation on all questions concerning standardization in the electrical and electronic fields. To this end and in addition to other activities, IEC publishes International Standards, Technical Specifications, Technical Reports, Publicly Available Specifications (PAS) and Guides (hereafter referred to as "IEC Publication(s)"). Their preparation is entrusted to technical committees; any IEC National Committee interested in the subject dealt with may participate in this preparatory work. International, governmental and non-governmental organizations liaising with the IEC also participate in this preparation. IEC collaborates closely with the International Organization for Standardization (ISO) in accordance with conditions determined by agreement between the two organizations.
- 2) The formal decisions or agreements of IEC on technical matters express, as nearly as possible, an international consensus of opinion on the relevant subjects since each technical committee has representation from all interested IEC National Committees.
- 3) IEC Publications have the form of recommendations for international use and are accepted by IEC National Committees in that sense. While all reasonable efforts are made to ensure that the technical content of IEC Publications is accurate, IEC cannot be held responsible for the way in which they are used or for any misinterpretation by any end user.
- 4) In order to promote international uniformity, IEC National Committees undertake to apply IEC Publications transparently to the maximum extent possible in their national and regional publications. Any divergence between any IEC Publication and the corresponding national or regional publication shall be clearly indicated in the latter.
- 5) IEC itself does not provide any attestation of conformity. Independent certification bodies provide conformity assessment services and, in some areas, access to IEC marks of conformity. IEC is not responsible for any services carried out by independent certification bodies.
- 6) All users should ensure that they have the latest edition of this publication.
- 7) No liability shall attach to IEC or its directors, employees, servants or agents including individual experts and members of its technical committees and IEC National Committees for any personal injury, property damage or other damage of any nature whatsoever, whether direct or indirect, or for costs (including legal fees) and expenses arising out of the publication, use of, or reliance upon, this IEC Publication or any other IEC Publications.
- 8) Attention is drawn to the Normative references cited in this publication. Use of the referenced publications is indispensable for the correct application of this publication.
- 9) Attention is drawn to the possibility that some of the elements of this IEC Publication may be the subject of patent rights. IEC shall not be held responsible for identifying any or all such patent rights.

International Standard IEC 60424-3 has been prepared IEC technical committee 51: Magnetic components and ferrite materials.

This second edition cancels and replaces the first edition published in 1999. This edition constitutes a technical revision.

This edition includes the following significant technical changes with respect to the previous edition:

- a) addition of allowable areas of chips for EC-cores in Table 3,
- b) addition of crystallites in 4.5 and pores in 4.6.

The text of this standard is based on the following documents:

FDIS	Report on voting
51/1099/FDIS	51/1114/RVD

Full information on the voting for the approval of this standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all parts in the IEC 60424 series, published under the general title *Ferrite cores – Guidelines on the limits of surface irregularities*, can be found on the IEC website.

Future standards in this series will carry the new general title as cited above. Titles of existing standards in this series will be updated at the time of the next edition.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC website under "<http://webstore.iec.ch>" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

FERRITE CORES – GUIDELINES ON THE LIMITS OF SURFACE IRREGULARITIES –

Part 3: ETD-cores, EER-cores, EC-cores and E-cores

1 Scope

This part of IEC 60424 gives guidelines on allowable limits of surface irregularities applicable to ETD-cores, EER-cores, EC-cores and E-cores in accordance with the relevant general specification.

This standard is a specification useful in the negotiations between ferrite core manufacturers and customers about surface irregularities.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 60424-1¹, *Ferrite cores – Guidelines on the limits of surface irregularities – Part 1: General specification*

IEC 60647, *Dimensions for magnetic oxide cores intended for use in power supplies (EC-cores)*

IEC 61185, *Ferrite cores (ETD-cores) intended for use in power supply applications – Dimensions*

IEC 62317-7, *Ferrite cores – Dimensions – Part 7: EER-cores*

IEC 62317-8, *Ferrite cores – Dimensions – Part 8: E-cores*

3 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

3.1

pore

hole left on the surface of cores after sintering and surface finishing

3.2

crystallite

grain of abnormal size distinguishable on the surface, often with sparkling facets

¹ To be published.